

<b>Notice of References Cited</b>	Application/Control No. 10/695,758	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Quochien B. Vuong	Art Unit 2685	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,121,162	10-1978	Alberkrack et al.	455/180.1
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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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